

P-Channel 14V(D-S) MOSFET

Product summary		
V _{DS}	-14	V
R _{DS(ON)} (at V _{GS} =-4.5V) Typ.	46	mΩ
R _{DS(ON)} (at V _{GS} =-2.5V) Typ.	65	mΩ
I _D (T _A =25°C)	-2.1	A

Features

- Trench Power LV MOSFET technology
- Low Gate Charge

Applications

- Power management
- Switching Circuits

Pin Configuration



Packing Information

Device	Package	Reel Size	Quantity(Min. Package)
ECDF2205	SOT-323	7"	3000pcs

Absolute Maximum Ratings (at T_A=25°C Unless Otherwise Noted)

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	-14	V
V _{GS}	Gate-Source Voltage	±10	V
I _D	Continuous Drain Current at V _{GS} =-4.5V	T _A =25°C	-2.1
		T _A =70°C	-1.7
I _{DM}	Pulse Drain Current Tested ^A	-11	A
P _D	Power Dissipation	0.4	W
T _J , T _{STG}	Junction and Storage Temperature Range	-55 to +150	°C

Thermal Characteristics

Symbol	Parameter	Typical	Units
R _{θJA}	Thermal Resistance-Junction to ambient ^B	312	°C/W

Electrical Characteristics (at $T_J = 25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
Static Parameters						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-14	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-12\text{V}, V_{\text{GS}}=0\text{V}$	--	--	-1	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=\pm 9\text{V}$	--	--	± 100	nA
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=-250\mu\text{A}$	-0.4	-0.6	-1.0	V
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance ^C	$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-2\text{A}$	--	46	60	$\text{m}\Omega$
		$V_{\text{GS}}=-2.5\text{V}, I_{\text{D}}=-1\text{A}$	--	65	90	$\text{m}\Omega$
V_{SD}	Forward Voltage	$I_{\text{SD}}=-1\text{A}, V_{\text{GS}}=0\text{V}$	--	--	-1.3	V
Dynamic Parameters ^D						
C_{iss}	Input Capacitance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=-10\text{V}$ $f=1\text{MHZ}$	--	140	--	pF
C_{oss}	Output Capacitance		--	112	--	pF
C_{rss}	Reverse Transfer Capacitance		--	25	--	pF
Q_g	Total Gate Charge	$V_{\text{DS}}=-6\text{V}, I_{\text{D}}=-2\text{A}$ $V_{\text{GS}}=-4.5\text{V}$	--	7	--	nC
Q_{gs}	Gate-Source Charge		--	0.9	--	nC
Q_{gd}	Gate-Drain Charge		--	1.8	--	nC
$t_{\text{D(on)}}$	Turn-on Delay Time	$V_{\text{DD}}=-6\text{V}$ $I_{\text{D}}=-2\text{A}, R_{\text{G}}=3.3\Omega$, $V_{\text{GS}}=-4.5\text{V}$	--	10	--	ns
t_r	Turn-on Rise Time		--	12	--	ns
$t_{\text{D(off)}}$	Turn-off Delay Time		--	27	--	ns
t_f	Turn-off Fall Time		--	20	--	ns

A. Pulse width limited by maximum allowable junction temperature.

B. The data tested by surface mounted on a 1 inch x 1 inch FR-4 board with 2OZ copper.

C. Pulse Test: Pulse Width $\leq 300\text{us}$, Duty cycle $\leq 2\%$.

D. Guaranteed by design, not subject to production testing.

Typical Characteristics

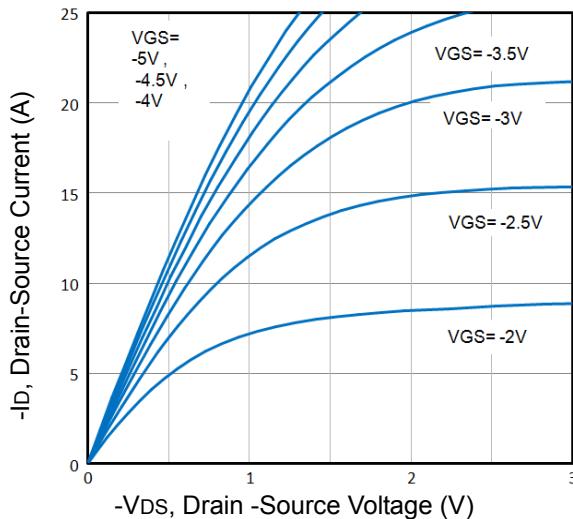


Fig1. Typical Output Characteristics

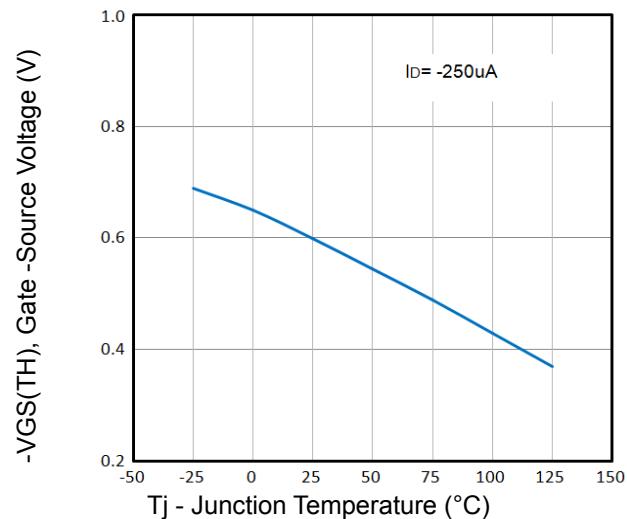


Fig2. $V_{GS(TH)}$ Voltage Vs. Temperature

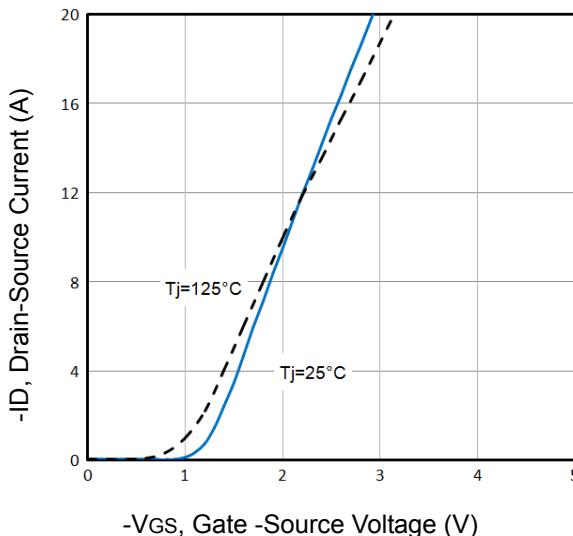


Fig3. Typical Transfer Characteristics

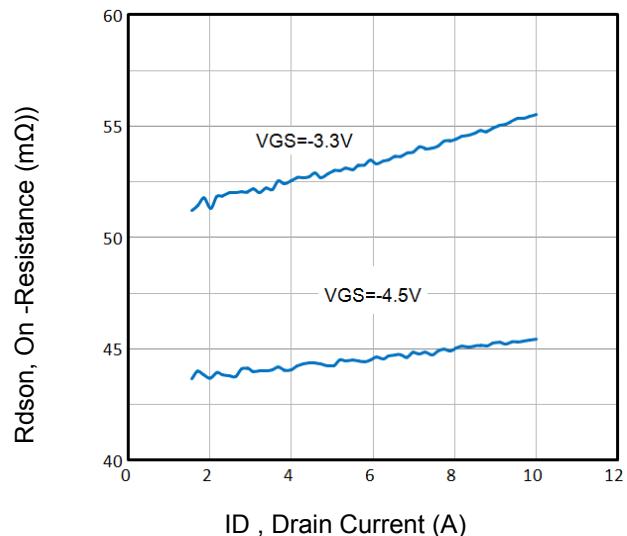


Fig4. On-Resistance vs. Drain Current and Gate V

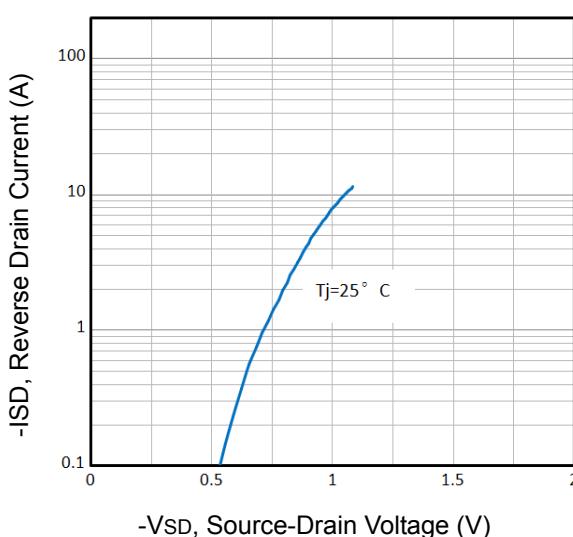


Fig5. Typical Source-Drain Diode Forward Voltage

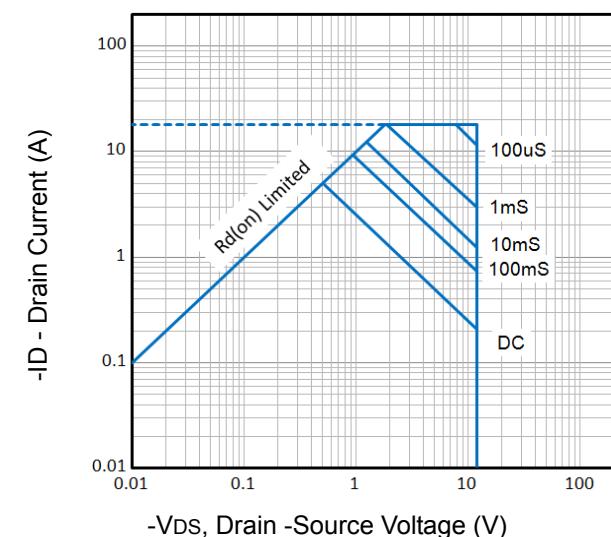


Fig6. Maximum Safe Operating Area

Typical Characteristics

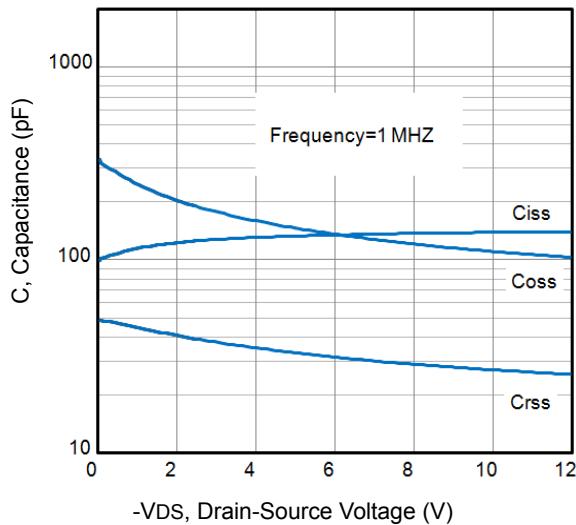


Fig7. Typical Capacitance Vs. Drain-Source Voltage

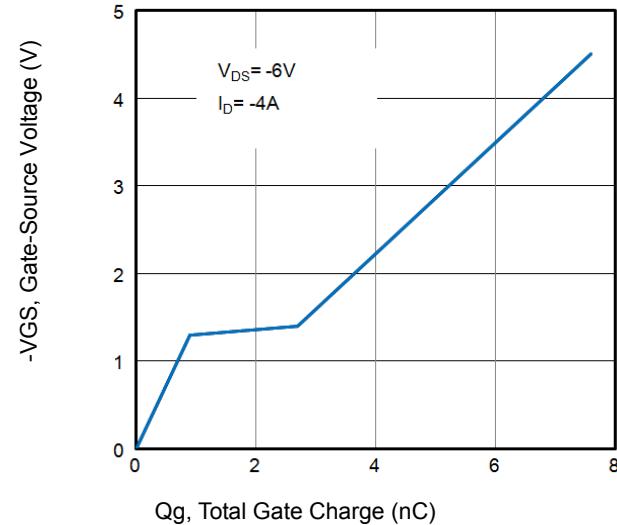


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

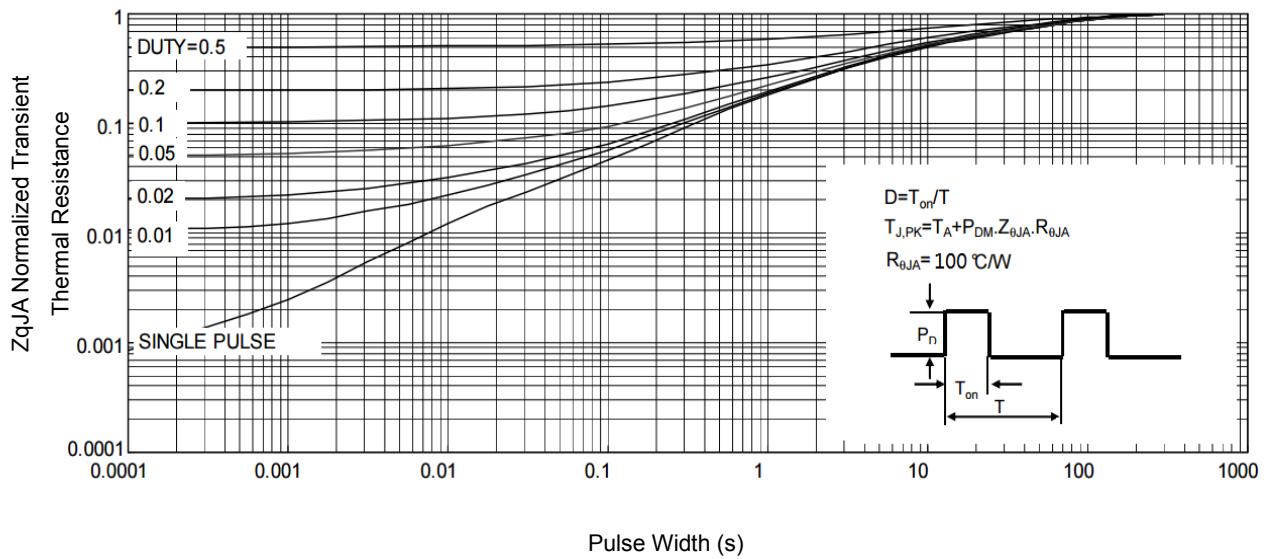


Fig9. Normalized Maximum Transient Thermal Impedance

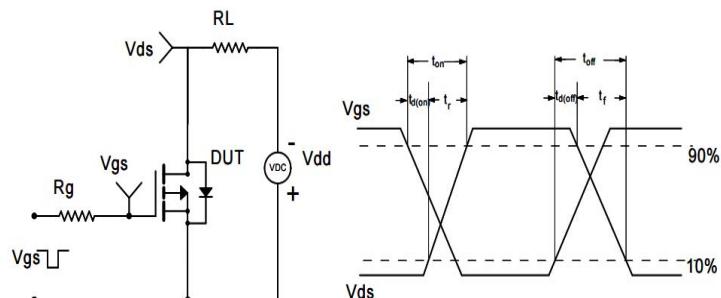
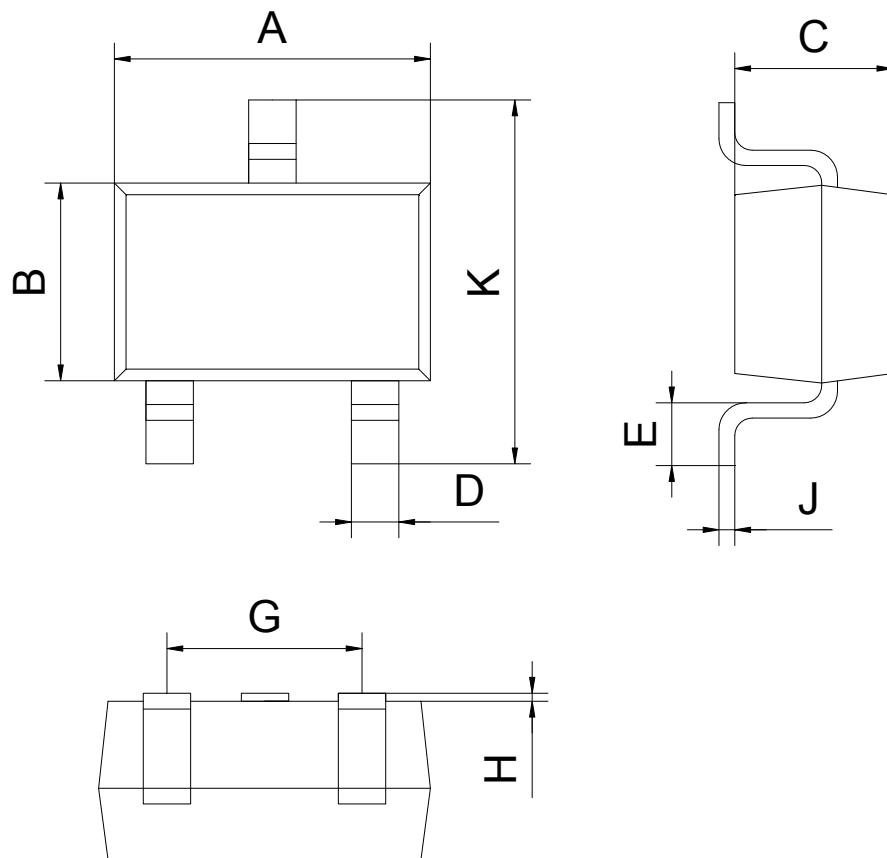


Fig10. Switching Time Test Circuit and waveforms

SOT-323 Package Information



SOT-323		
Dim	Min	Max
A	2.00	2.20
B	1.15	1.35
C	0.90	1.10
D	0.15	0.35
E	0.25	0.40
G	1.20	1.40
H	0.02	0.10
J	0.05	0.15
K	2.20	2.40
All Dimensions in mm		